

Patterning

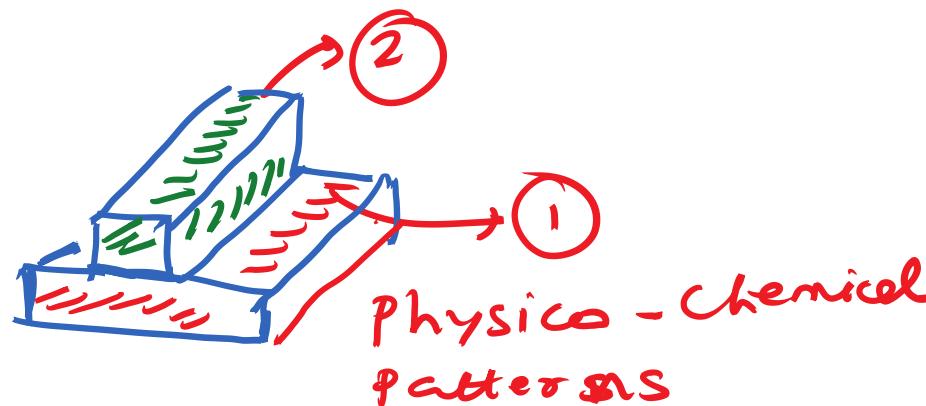
What exactly is a Topographically Patterned Surface?

Photolithography



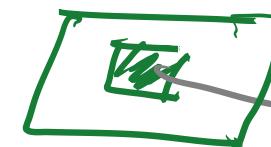
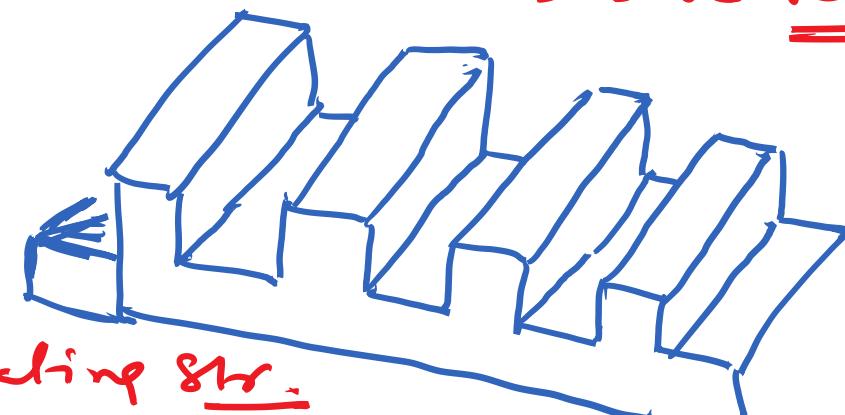
Chemical Patterns

Topographic Patterns

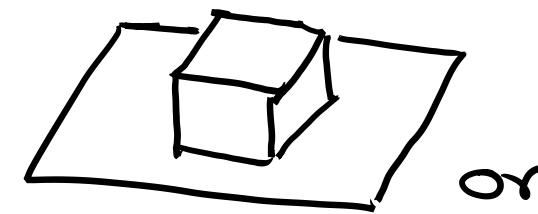


Chemically Homogeneous

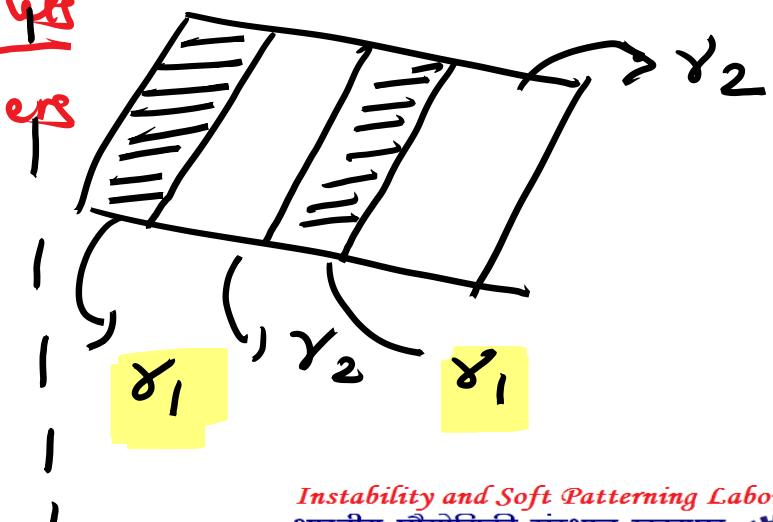
Line Grating Str.



Different Chemical Properties.



Dewetted Droplets
Disordered Patterns



Top Down Approaches:: Lithography

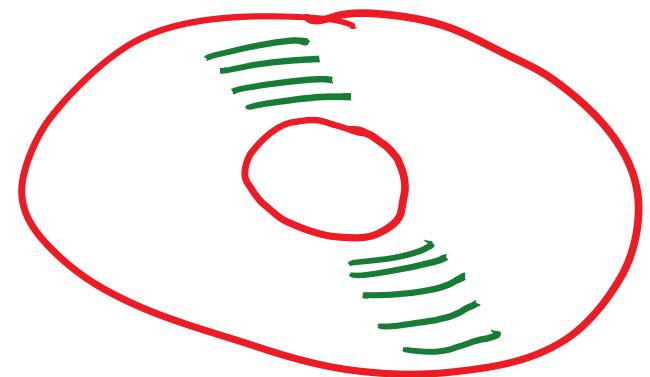
- **Photolithography**
 - **Soft Lithography**
 - Micro contact printing
 - Nano Imprint Lithography group of methods
 - Capillary Force Lithography
 - Micro Molding in Capillaries
- Diffraction of Light →
Rainbow Color on the back side of a CD.
- Insect Vision / Change of Color like

(1) How do you make such Topographic Patterns.

(2) What are the potential applications of such patterns.

→ Structural Superhydrophobic
→ Self Cleaning surfaces.

Back Side of a Compact Disc,



Some Topographic Patterns →
Which have feature size
Comparable to the WL of Visible
Light →

Structural Color

The BIGGEST application area of Patterning



Pentium II processor

200 M Hz Clock Speed

500 MBHDD

1999

To what is this change attributed to?

Intel Core i9-9980XE

4.5 GHz speed

5 TB HDD

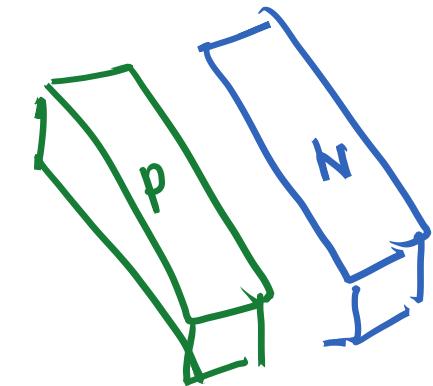
2019



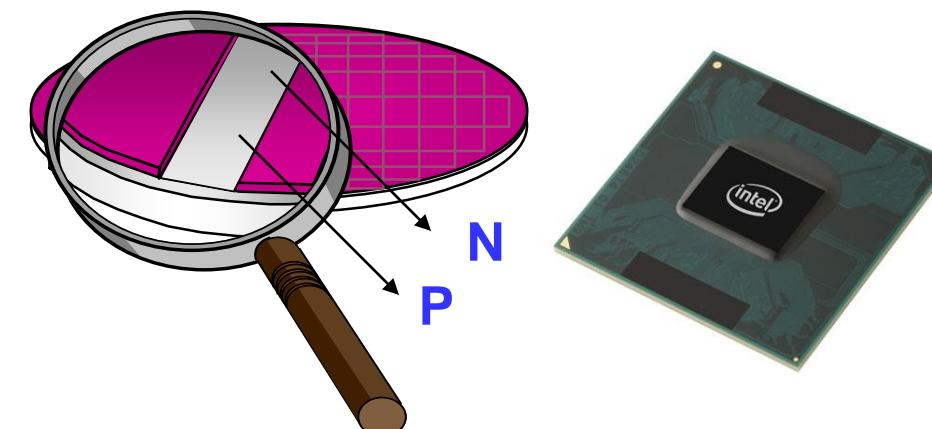
Patterning in Micro Electronics

The micro electronic industry
PC, Laptop, Cell Phone, i-pod

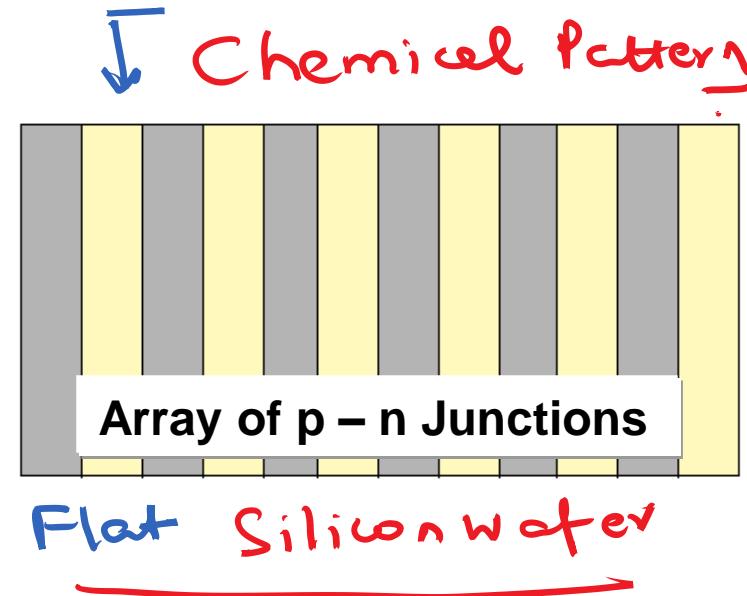
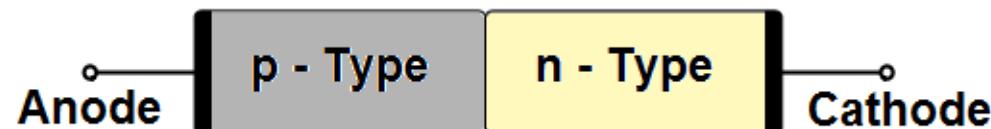
Have you ever thought how every year the speed of the computer processor becomes faster or how the memory sizes increases?



Reality is the tremendous progress in the field of micro electronics industry is attributed to the progress of a specific patterning technique, which is known as photolithography.



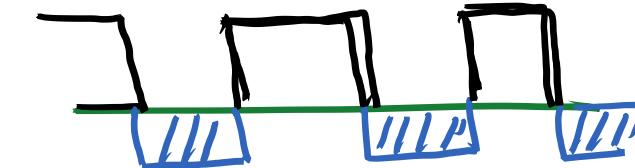
The p – n Junction



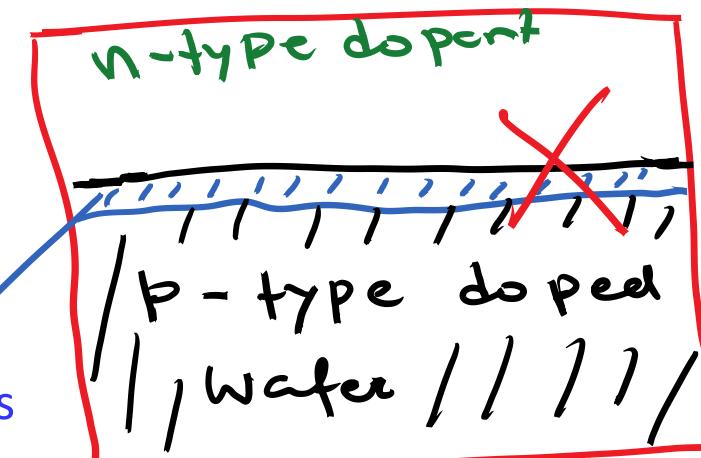
- A p-n junction is formed at the boundary between a p-type and n-type semiconductor.
- If two separate pieces of material were used, this would introduce a grain boundary between the semiconductors which severely inhibits its utility by scattering the electrons and holes.
- so p-n junctions are created in a single crystal of semiconductor by doping
- P-N junctions are elementary "building blocks" of many semiconductor electronic devices such as diodes, transistors, solar cells, and integrated circuits

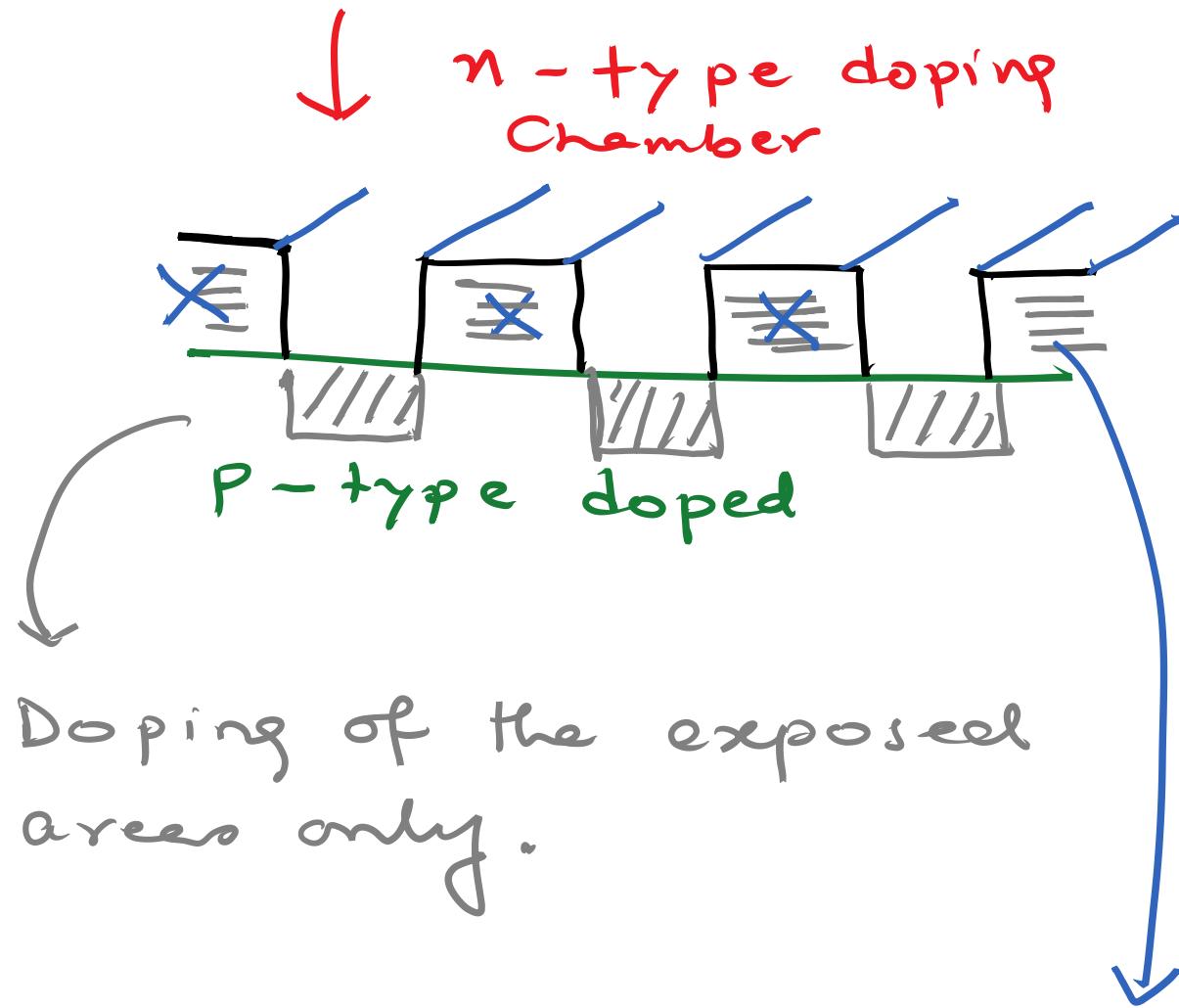
n - type doping over the entire surface.

Some P-



Silicon
p - type doped.

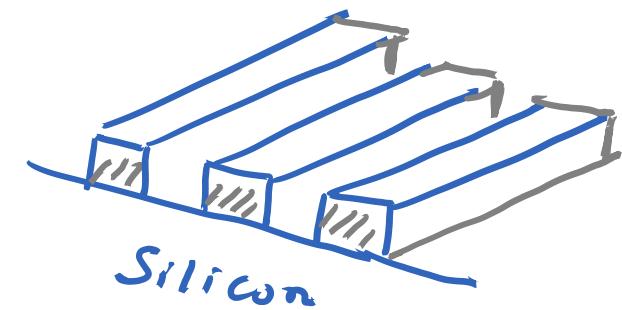




(1) Some topographic features on the wafer
 (of a material that does not react / degrade and prevents diffusion of the dopant)

(2) Place in n - type doping chamber.

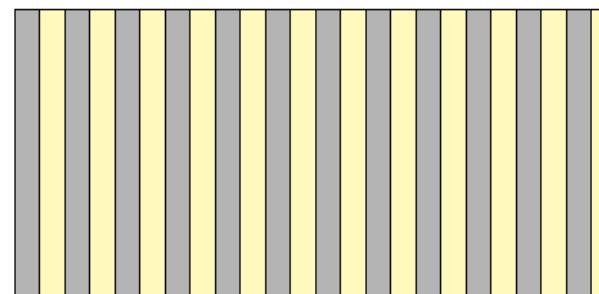
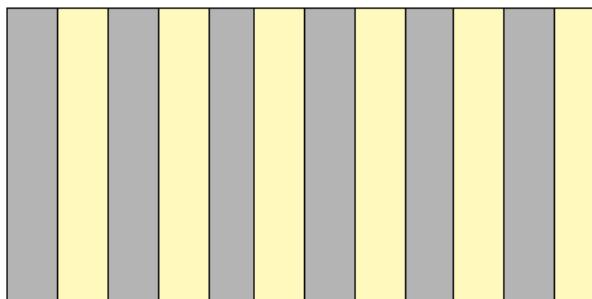
Diffusion Barrier



Physics - Chemical Pattern.

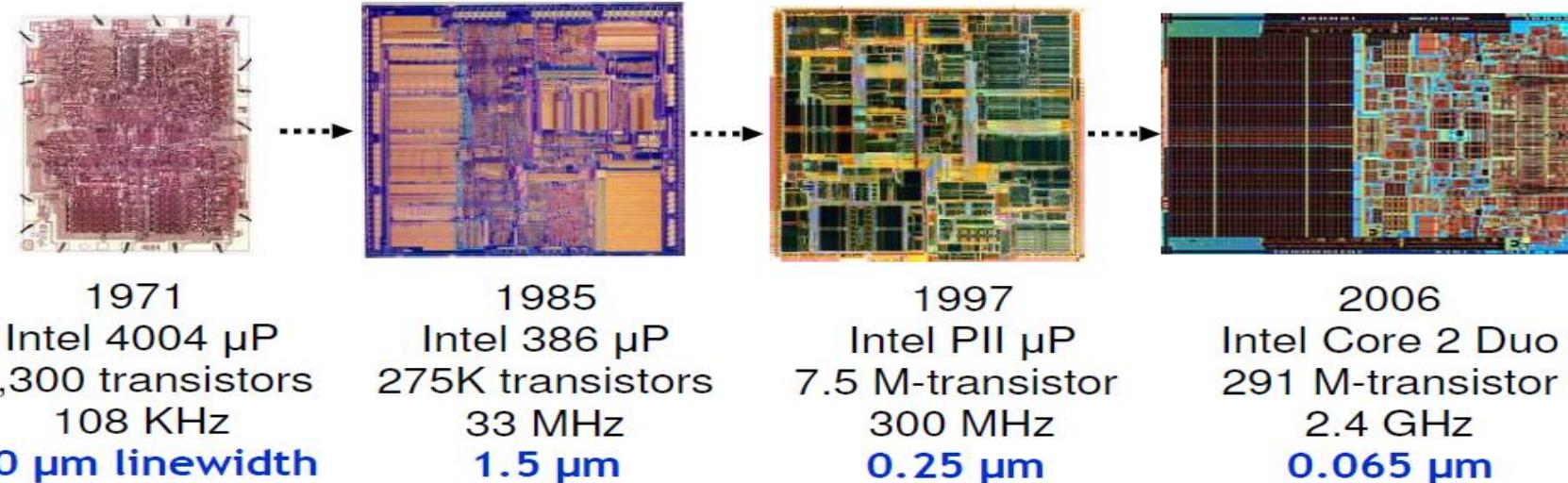
30.03.2022

The p – n Junction



- So simply put if your lines become narrower, you can have more number of p – n junctions on a chip whose physical dimensions are the same.
- These lines are created by the method of Photolithography.
- For example while a Pentium II processor had lines which are 300 nm wide, the lines are about 32 nm wide in a i-core 5 processor.
- Similarly progress in patterning is also responsible for higher capacity memories.

Intel Microprocessors – Brief History

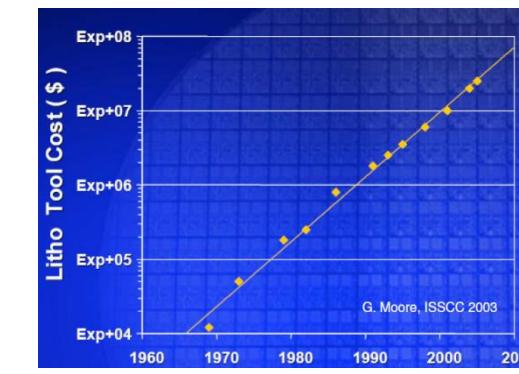
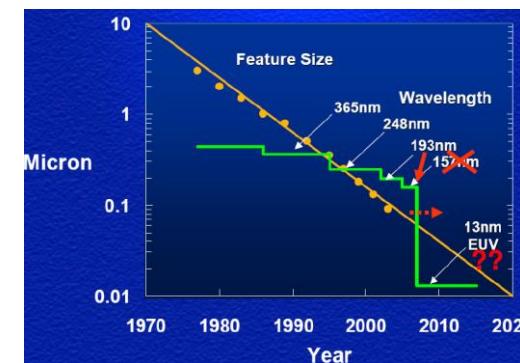


Historically, advances in microelectronics have been due to ability to making smaller and denser patterns.

→ Photolithography has been the workhorse of the semiconductor industry.

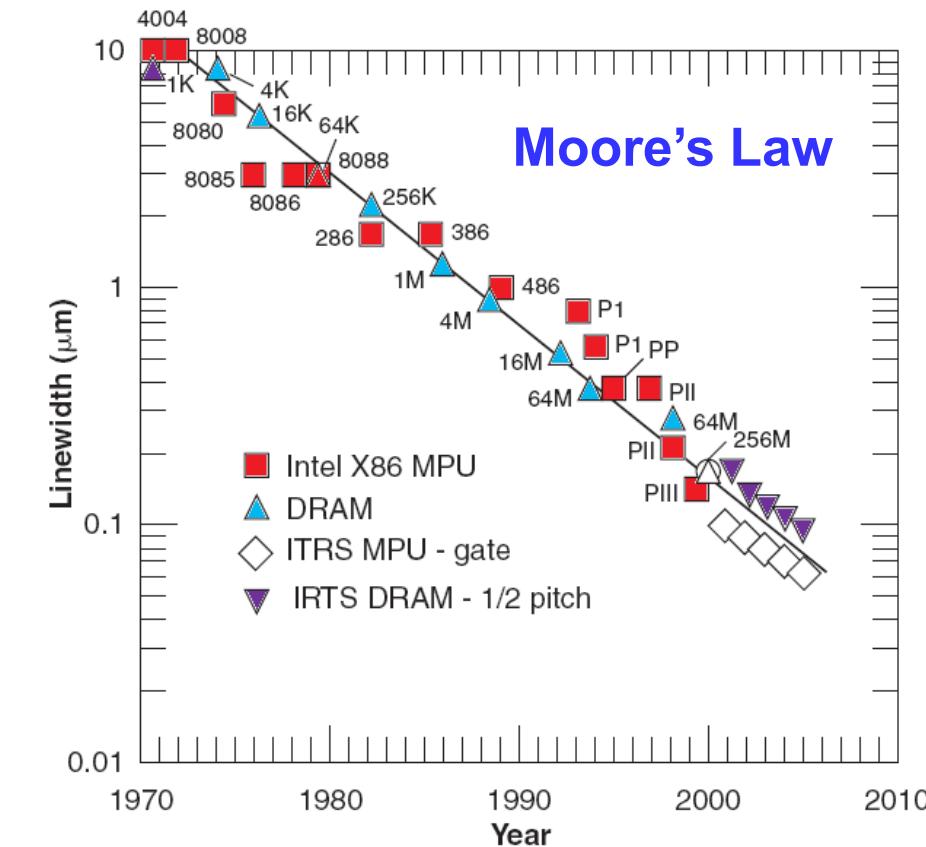
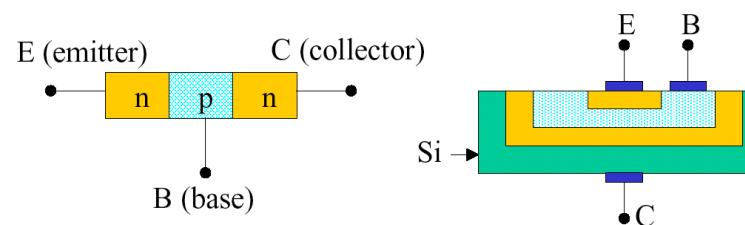
→ Lithography is key technology pacing Moore's Law

4

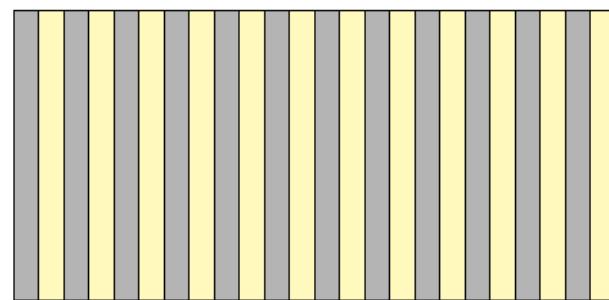


Photolithography

- Innovations in the integrated circuit industry is the main motive force for the tremendous advance in the field of surface patterning.
 - Transistor invented in 1947.*
 - The first Integrated Circuit built in 1960. The line width in integrated circuits was 5 μm .*
 - First IBM PC (1981), 16 K Byte memory, 4.77 MHz clock speed.*
 - Line widths of 350 nm was achieved, when 40 GB D-RAM was discovered in 1997.*
 - Present state $\sim 40 \text{ nm}$.*
- Narrower is the line size, closer is the packing, better is the performance of the circuit!

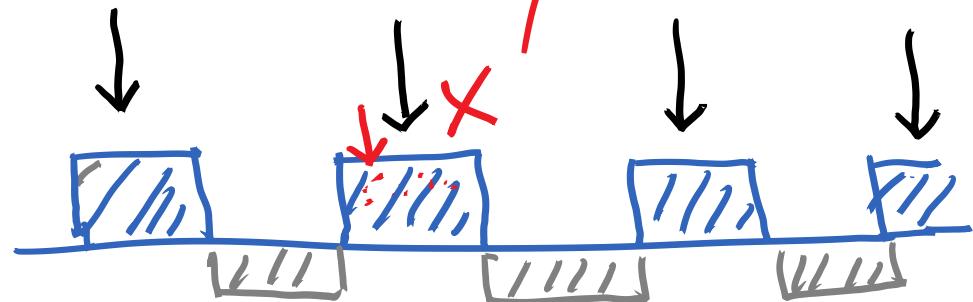


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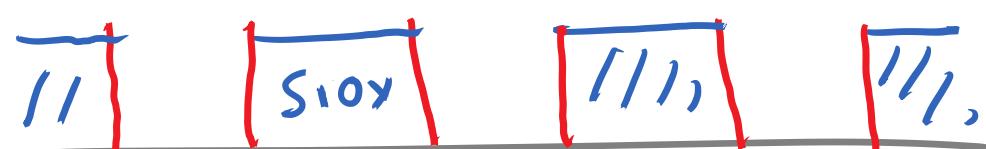


Dopants won't diffuse →

Doping Reagents to reach the surface (Silicon Oxide)



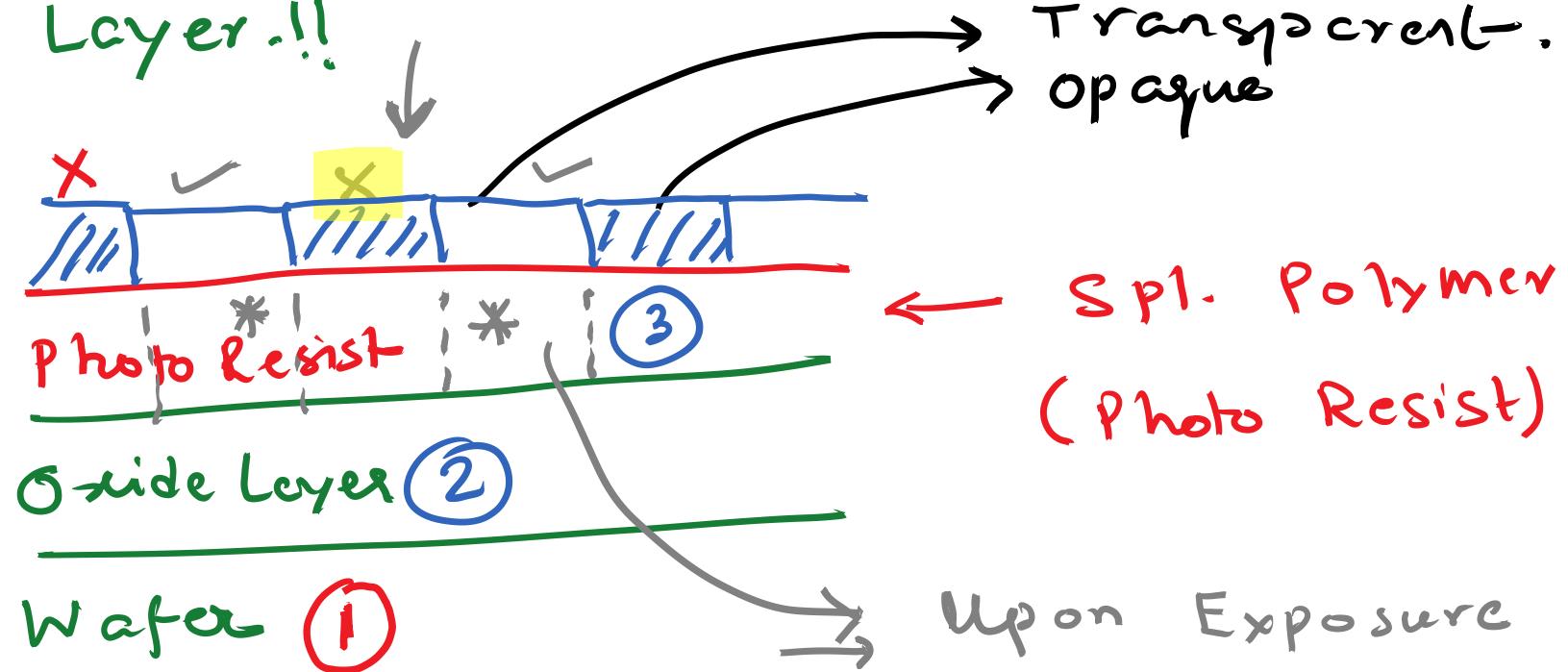
n or p doped wafer with which you start



- (1) First take Oxide layer
- (2) Then scrape out some pads

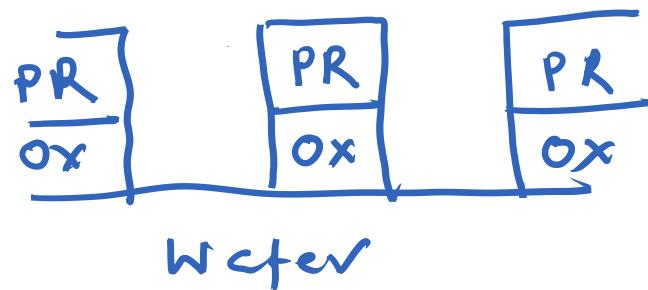


The patterns cannot be directly made in the Oxide Layer !!

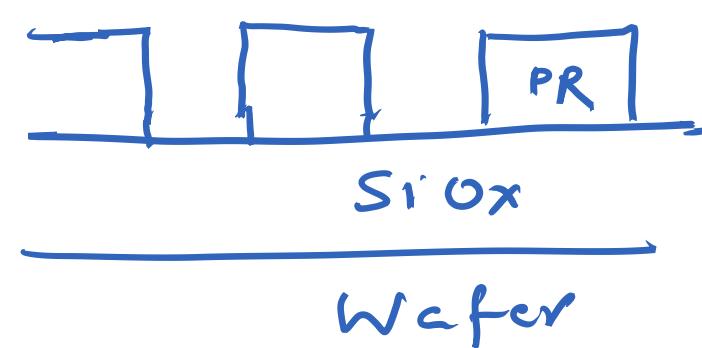
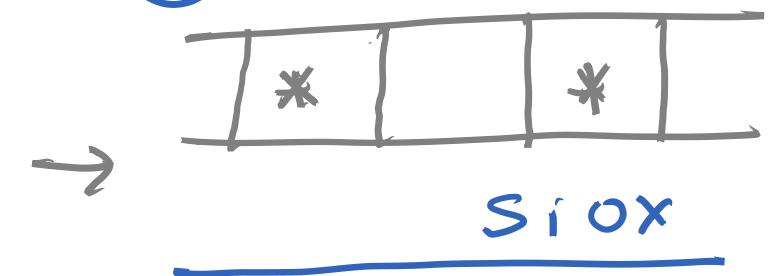


Spl. Polymer
(Photo Resist)

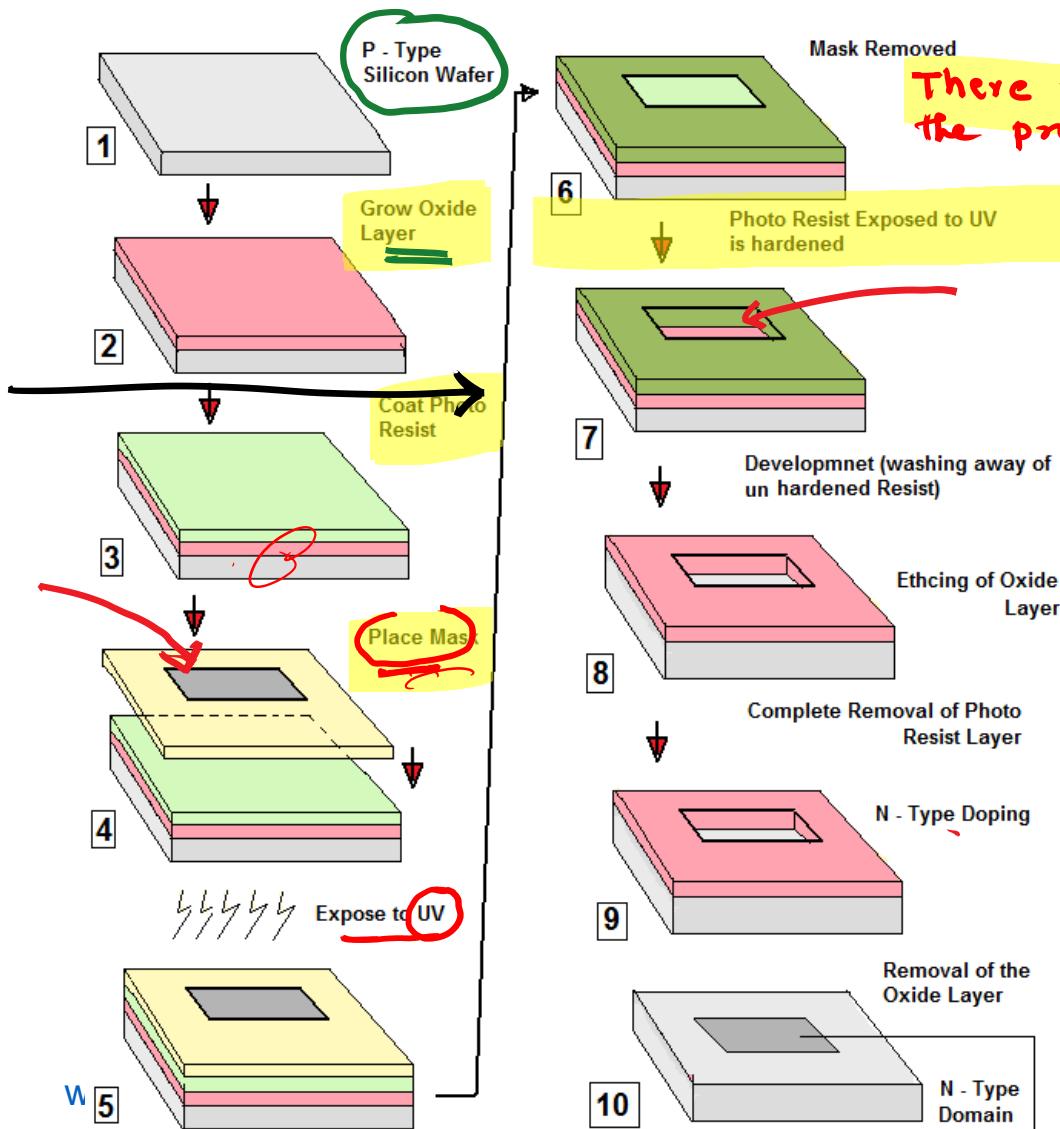
Upon Exposure
these Zones will
undergo some
Change in properg.



- ① Water
- ② Grow Oxide Layer
- ③ Spin Coat PR.
Place-Mask + Expose
- ④ Wash



Photolithography Process: Basic Steps



There is some change in the property of the PR layer between areas that are Exposed or Not!

Silicon Wafer

Photo resist

Spin Coating

Mask

Optical Source

Mask Aligner

Developer

Etching

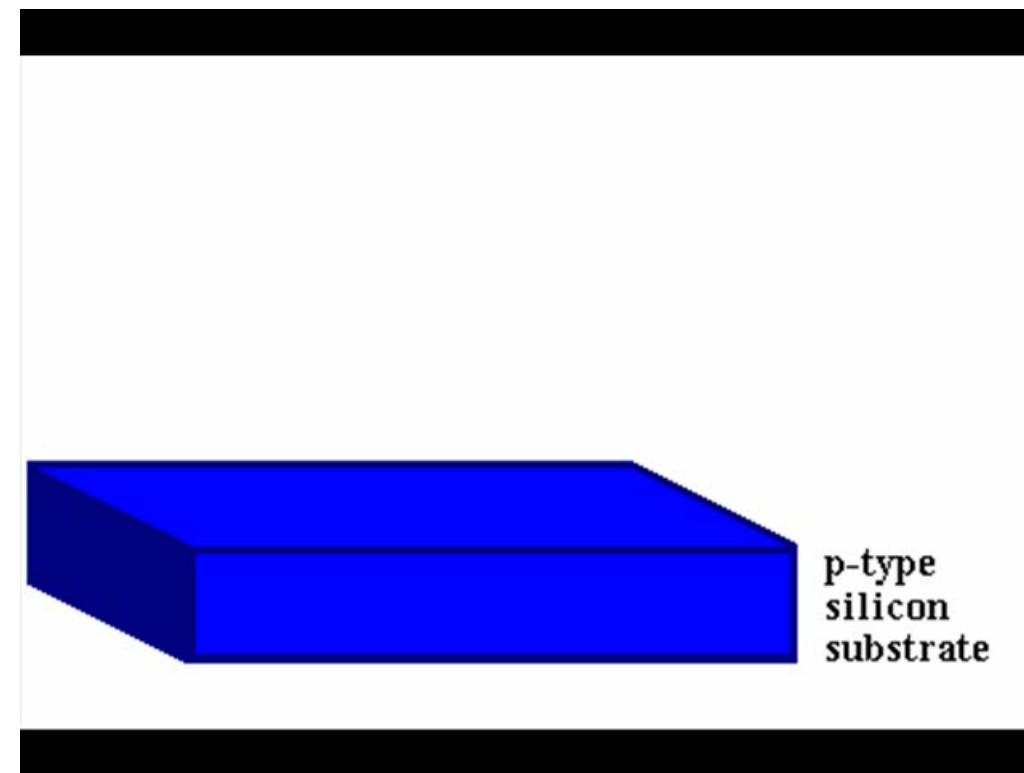
After Stage 2

Ox

Silicon Wafer

Photolithography Process: Basic Steps

1. Surface Preparation
2. Deposition of the Barrier Layer (SiO_2)
3. Photoresist Application
4. Soft Bake
5. Mask Align
6. Expose to UV
7. Develop
8. Hard Bake
9. Etch
10. Resist Strip



Wafer Cleaning

In the first step, the wafers are chemically cleaned to remove particulate matter on the surface as well as any types of organic, inorganic and metallic impurities.

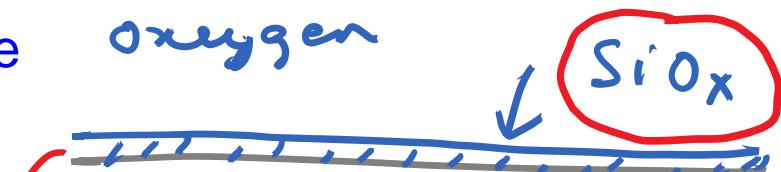
Barrier Formation

A Silicon Surface has very high surface energy and oxidizes immediately in contact with air. This oxide layer is very thin. This silica layer itself cannot be used as a barrier. So, SiO₂ layer is grown on the wafer at this stage.

Photo Resist Processing

Photo resist is coated on to the substrate by the method of spin coating, in most cases. It is possible to obtain films which are very thin (down to few nm) and are extremely smooth by the method of spin coating.

Spontaneous Surface Rxn with Oxygen



Silicon

very High γ
 $\approx 430 \frac{\text{mJ}}{\text{m}^2}$

Native Oxide Layer.

Thk $\sim 1.8 \text{ nm}$

Still Grow the Thk of Oxide.



Silicon Water

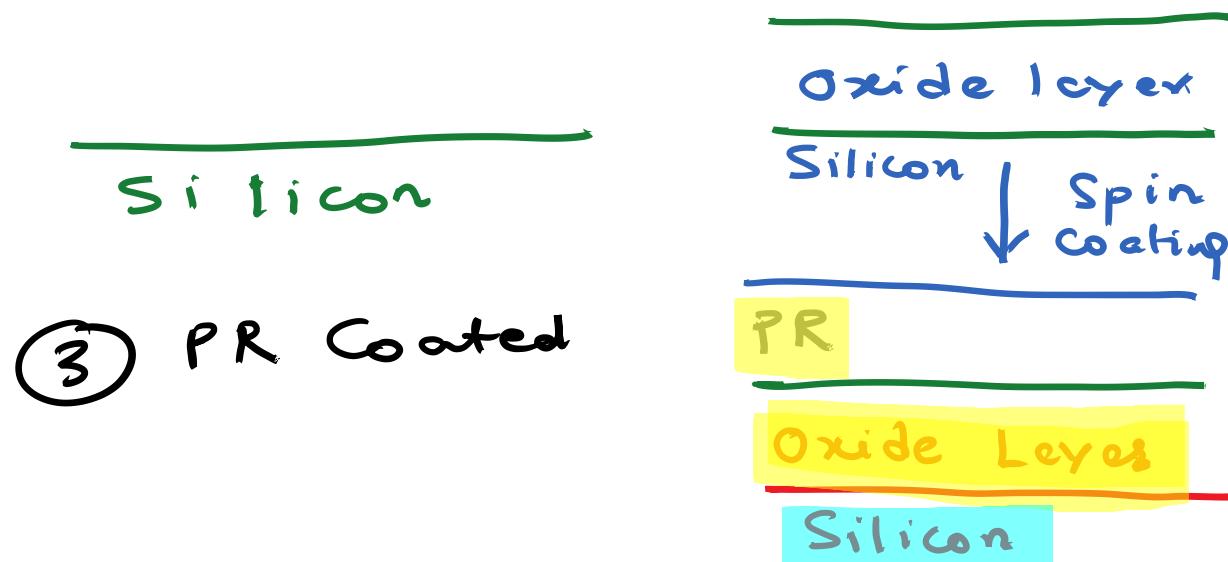


Photo Resist Processing

Consists of Six steps:

- 1) Dehydration and Priming
- 2) Resist coating → Spin Coating .
- 3) Soft baking → Dry PR Layer
- 4) Exposure
- 5) Development and
- 6) Post-development inspection.

*→ Despite the presence of Native Oxide Layer - we further need to grow the Ox Layer → To make the Layer thick enough to prevent diffusion.



③ PR Coated



Photo Resist

It's a special class of Photo Sensitive Polymer.

Photoresist layers have two basic functions:

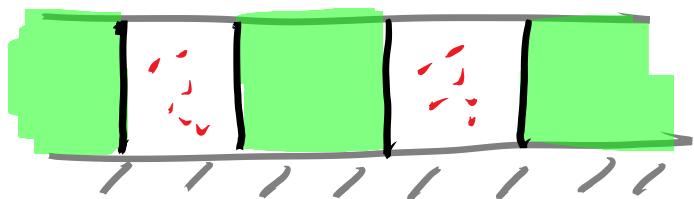
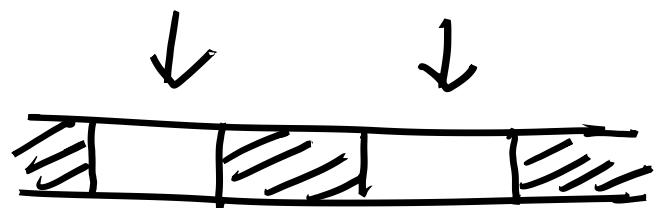
- 1) precise pattern formation; and
- 2) protection of the substrate from chemical attack during the etch process.

Typical resists consist of three components:

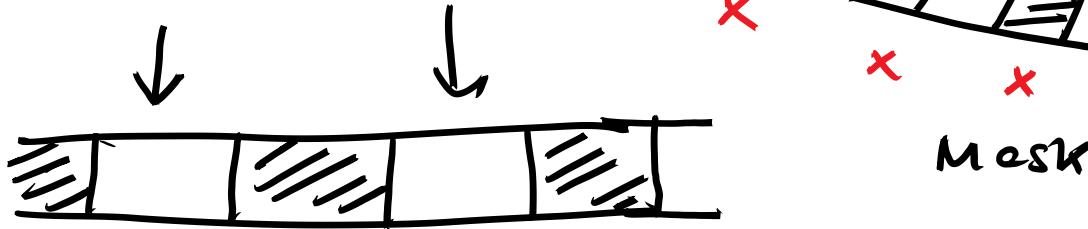
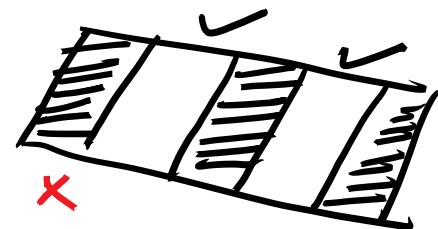
- 1) The resin, which serves as the binder of the film;
- 2) The inhibitor or sensitizer, which is the photoactive ingredient; and
- 3) The solvent, which keeps the resist in liquid state until it is processed.



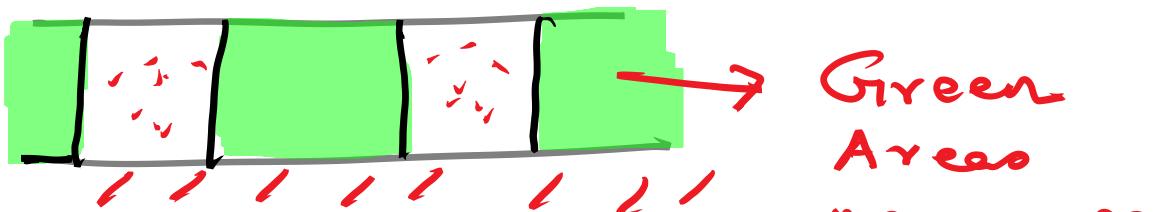
Photo Resist → Different PR Tones.



The
Spotted
Areas there
is some
Change



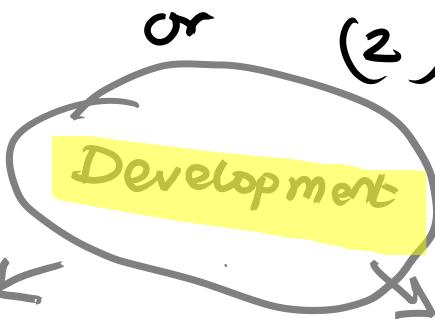
Mask



Green
Areas
no change

in PR
property

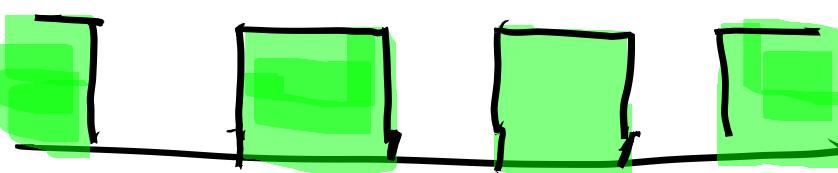
(1) The exposed Areas
have got stronger



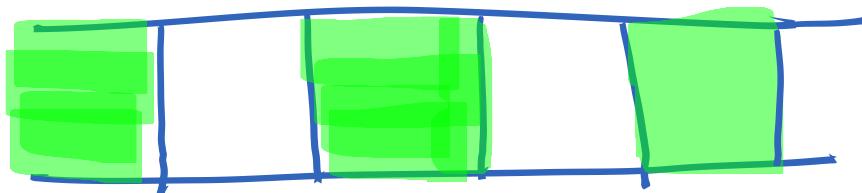
(Exposed PR Layer is
now washed with a solvent-
for the PR)

(2) The exposed
Areas have got
weaker,

Exposed PR Layer upon
Solvent washing →



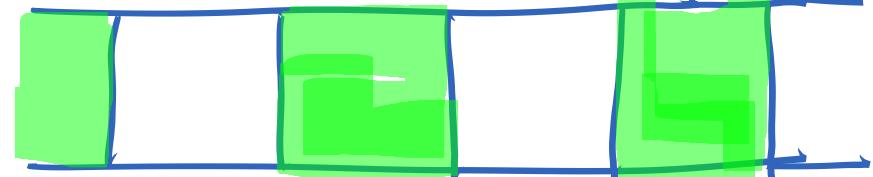
Chain Scission



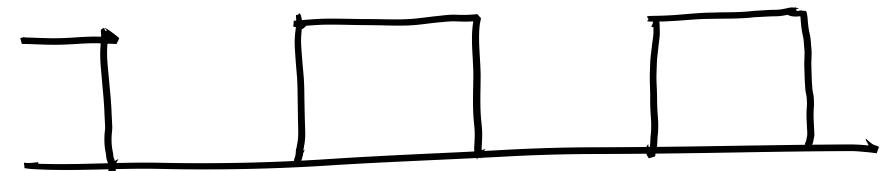
↓ Develop



This got strengthened



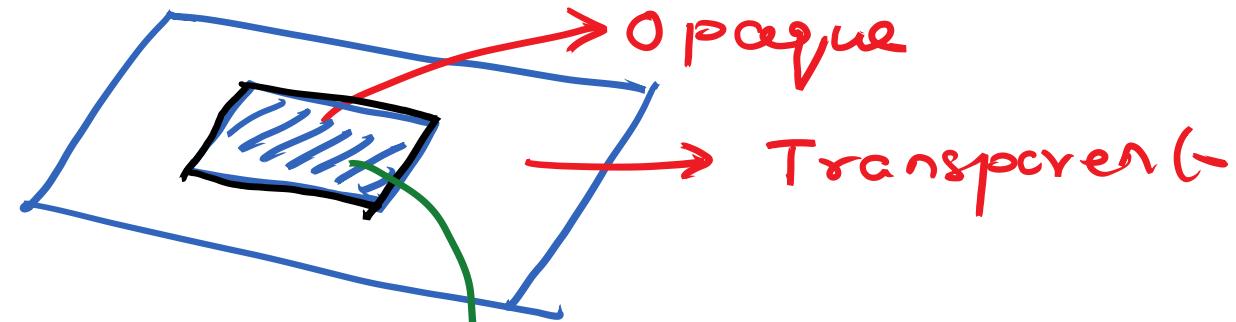
↓ Develop.



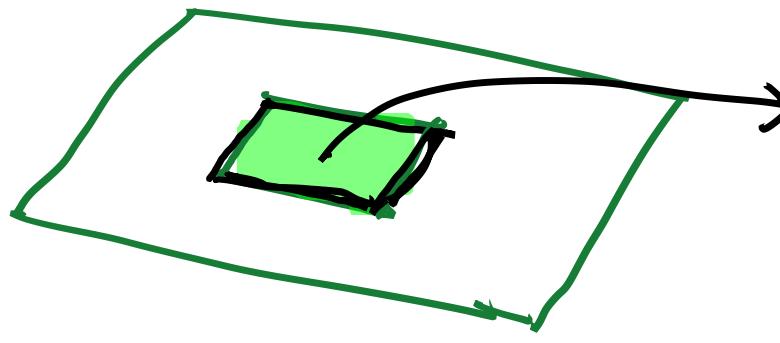
This got weakened

Exposed port

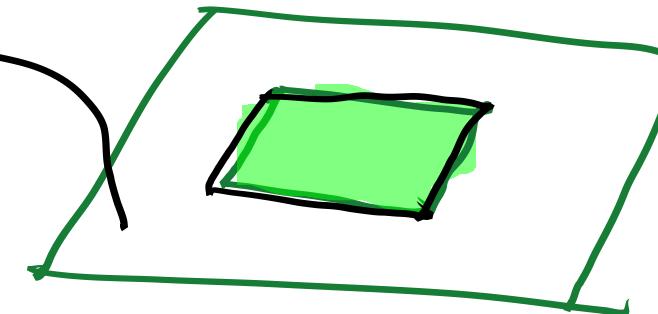
Strengthens



Exposed
Port
weakens



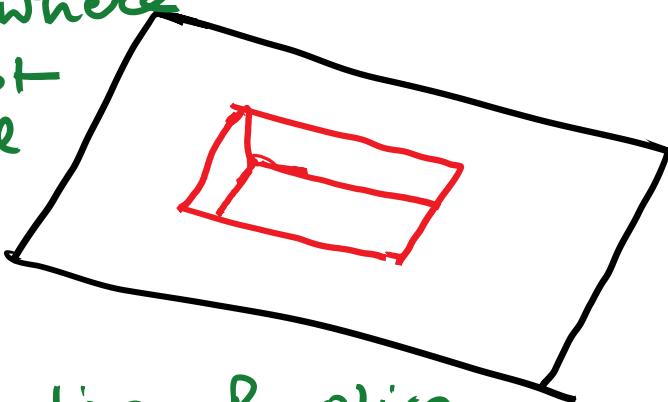
To get removed



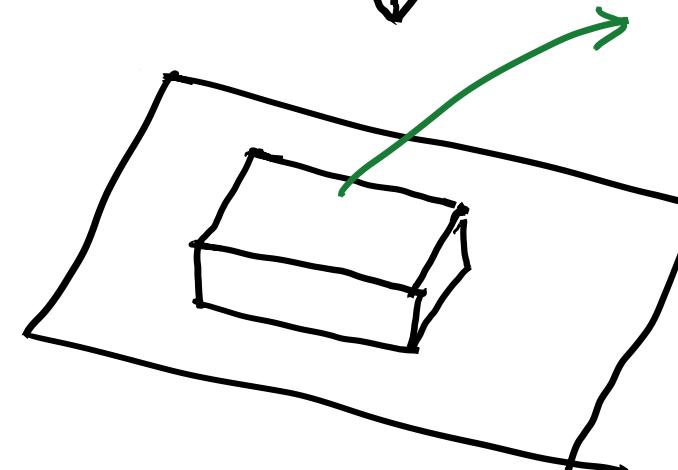
Development-

Original
Mask
had
feature
at the
central
zone

Feature
Everywhere
Except
Central
Zone



Negative Replica

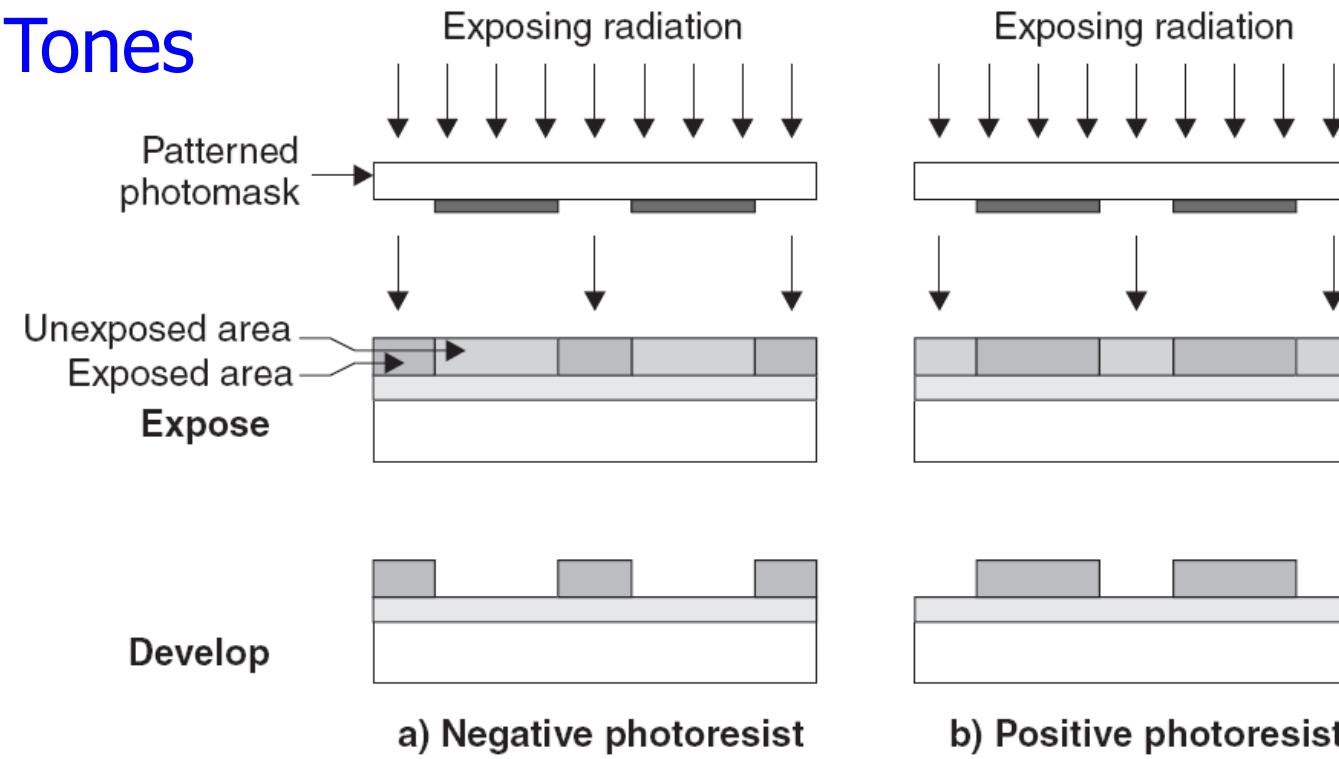


Feature at-
Central Zone

Positive
Replica.

1. A photo resist that upon Exposure, creates a **positive Replica** is a **Positive PR**
(Exposed Posts to weaken)
2. A PR that upon Exposure creates a **Negative Replica** is a **Negative Photo Resist**
(Exposed Post to strengthen),

Photo Resist Tones



Present Day most ICs are fabricated based on Positive Photo resists

SU 8 is a very popular Negative Resist

AZ 111 XFS example of a Positive Resist

Modern Resist that work with DUV light (248 nm) have much higher sensitivity

Characteristic	Positive	Negative
Adhesion to Si	fair	excellent
Relative cost	more	less
Developer Base	aqueous	organic
Minimum	0.5 μm	2 μm
Step Coverage	better	lower
Wet Chemical Resistance	fair	excellent



Photo Resist

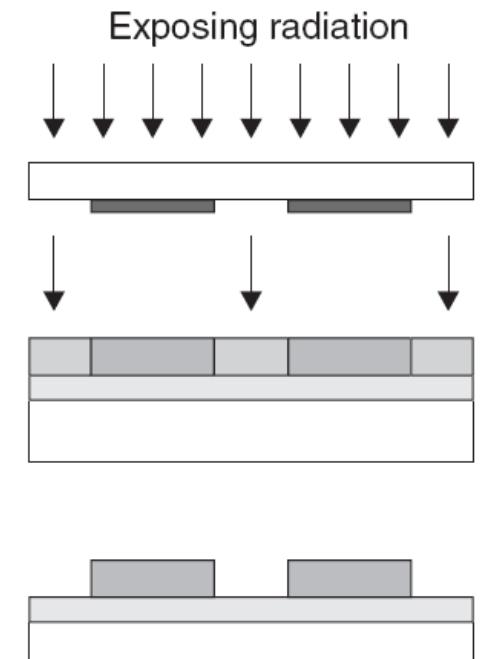
There are two different types of photo resists:

Positive and Negative. (Tones)

A Positive Photo resist when exposed to UV light undergoes structural changes (degradation) and becomes more soluble in the developer.

The exposed resist is then washed away by a developer solution.

An exact copy of the mask pattern is created on the resist layer (positive replica)



b) Positive photoresist

The First Commercial Photoresist was a Negative Photo Resist: Kodak Thin Film Resist



Photo Resist Processing

Consists of Six steps:

- 1) Dehydration and Priming ✓
- 2) Resist coating ✓
- 3) Soft baking ✓
- 4) Exposure ✓
- 5) Development and ✓
- 6) Post-development inspection.

Dehydration and Priming

Before the resist is coated, the wafer must be free of moisture and contaminants, both of which cause a severe problem in resist processing.

Dehydration baking is performed to eliminate any moisture adsorbed on the wafer surfaces, as hydrated substrates lead to adhesion failures.

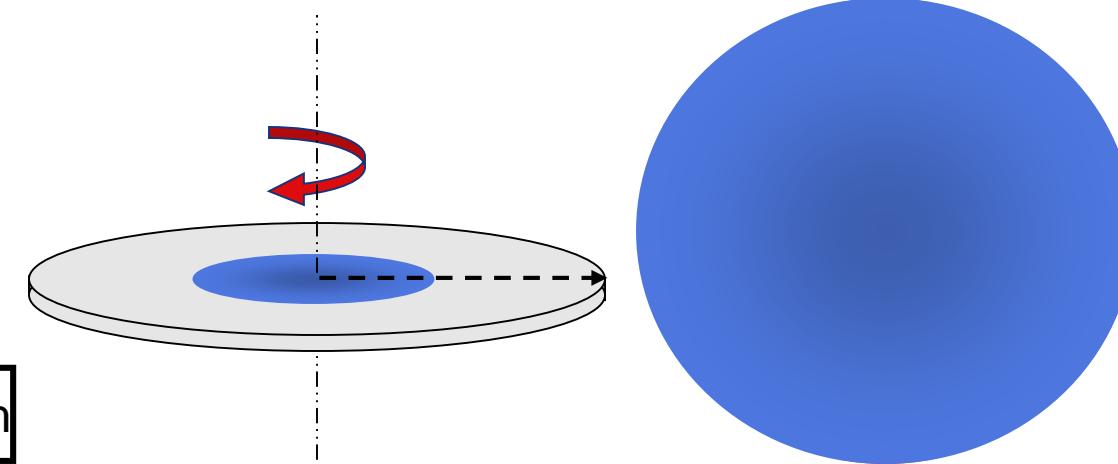
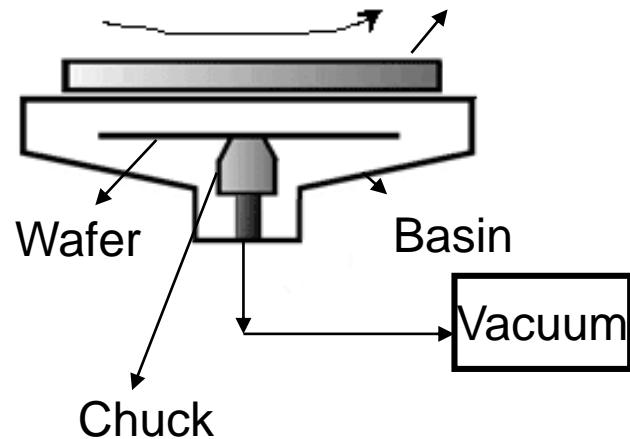
This is usually performed by heating to temperatures between **400 °C** to **800 °C**.

After dehydration baking, the wafer is coated with a pre-resist priming layer which enhances the adhesion properties of the wafer.

One of the most common primers used for this purpose is hexamethyldisilazane (HMDS). Resist coating must follow as soon as possible after priming

Spin Coating

- A process in which solution is spread evenly over a surface using centripetal force.
- Spin coating will result in a relatively uniform thin film of a specific thickness.
- Spin coating is an important way of creating thin films in the microelectronics industry.



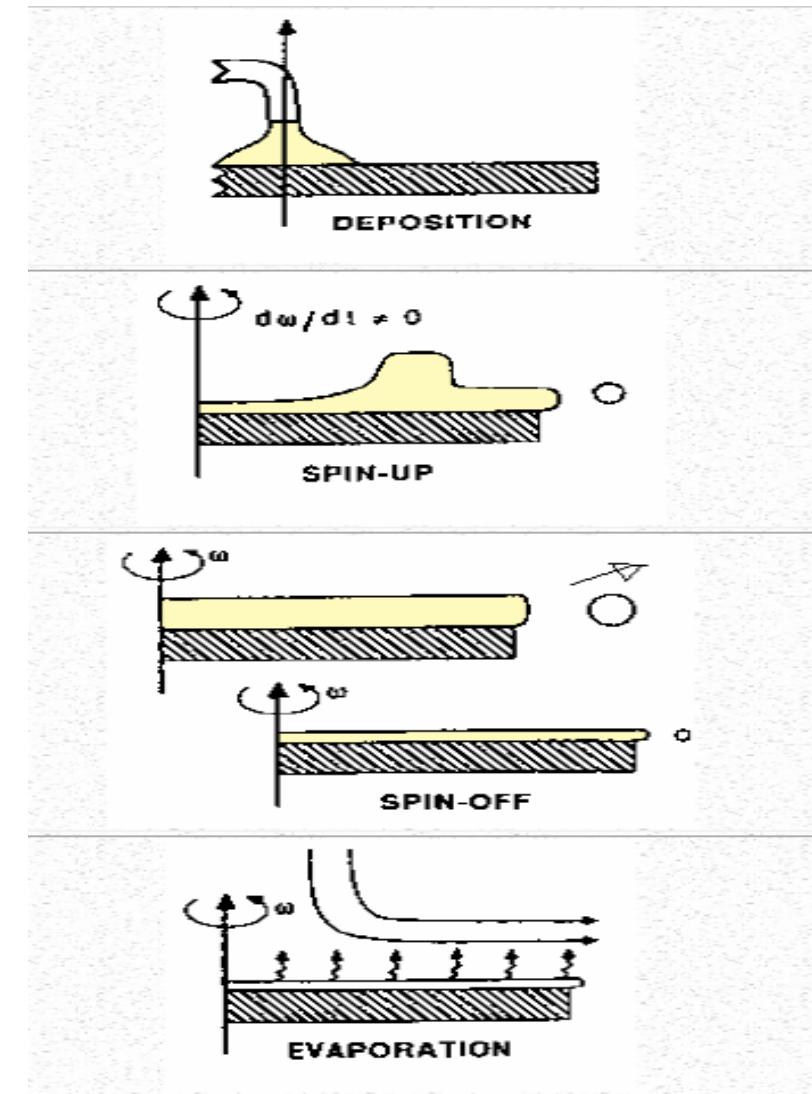
Different Steps of Spin Coating

Dispense the
Polymer Solution

Stage 1:
Meniscus traveling From
Centre to Edge

Stage 2:
Splash Drainage From
the Edges

Stage 3:
Evaporation dominated
Drying



Parameters Affecting Film Thickness in Spin Coating

Spin Speed (RPM)

Spin Coating is followed
by Edge Bead Removal

Dispensed drop volume

Choice of Solvent

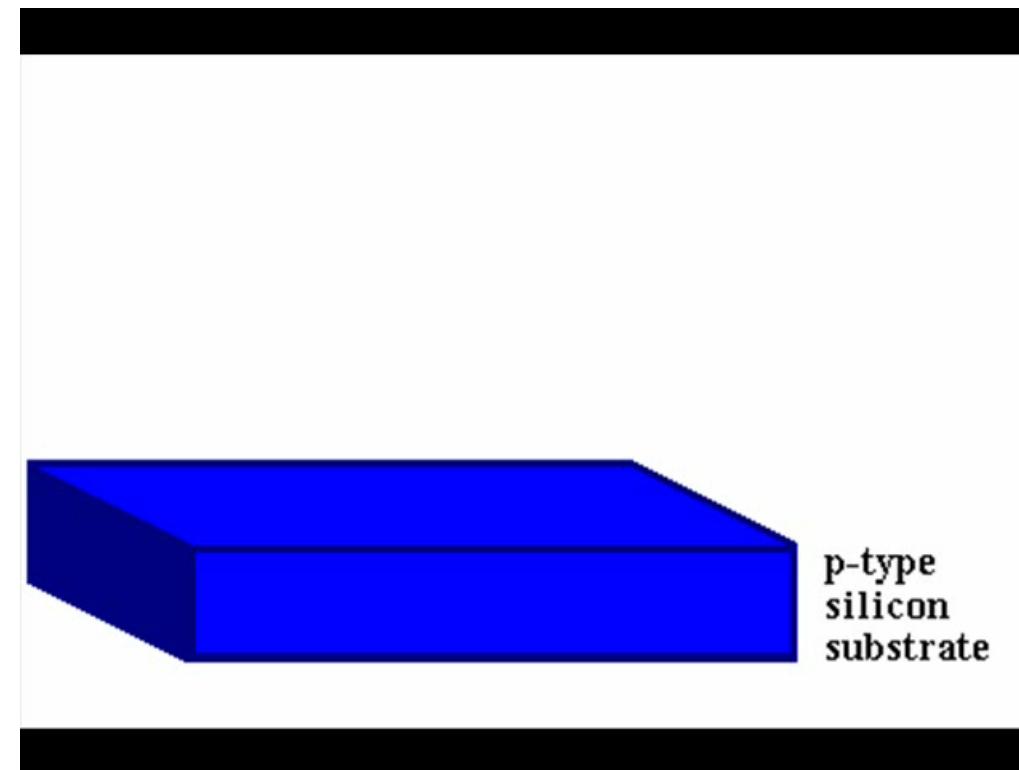
Duration of Spinning

Ambient Condition

(which in turn affects the solvent evaporation rate)

Photolithography Process: Basic Steps

1. Surface Preparation
2. Deposition of the Barrier Layer (SiO_2)
3. Photoresist Application
4. Soft Bake
5. Mask Align
6. Expose to UV
7. Develop
8. Hard Bake
9. Etch
10. Resist Strip



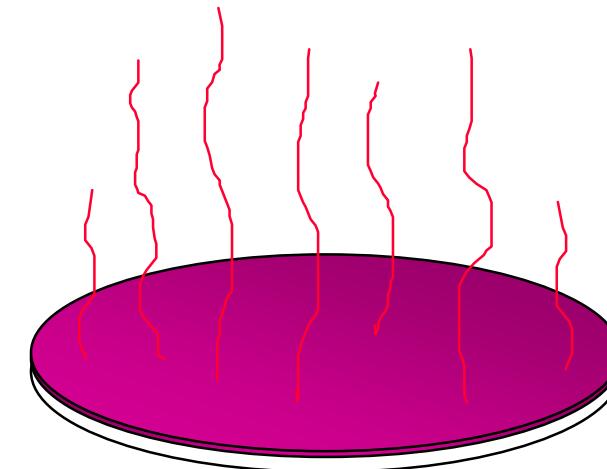
Soft Baking → To remove the Entrapped Solvent.

After spin coating, the solvent content in the as cast film drops to around 10 – 20%.

The remnant solvent has to be removed before exposure, which is achieved during the stage of Soft Baking.

The photoresist coatings become photosensitive, or imageable, only after soft-baking.

- Improves adhesion
- Improves uniformity
- Improves etch resistance
- Improves linewidth control
- Optimizes light absorbance characteristics of photoresist



Temperature: 90 - 110 °C

When to Stop rotation in Spin Coating?

Spin Coating a Polymer, within the film matrix, there is ENTANGLEMENT



About 10 - 20% Solvent Remains stuck within the matrix.



Soft Baking

Over soft-baking will degrade the photosensitivity of resists by either reducing the developer solubility or actually destroying a portion of the sensitizer.

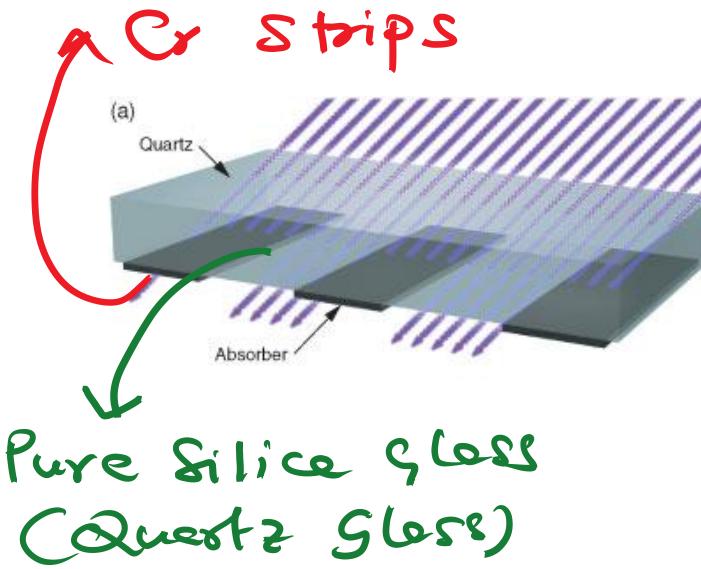
Under soft-baking will prevent light from reaching the sensitizer. Positive resists are incompletely exposed if considerable solvent remains in the coating.

A under soft-baked positive resists is readily attacked by the developer in both exposed and unexposed areas, causing less etching resistance

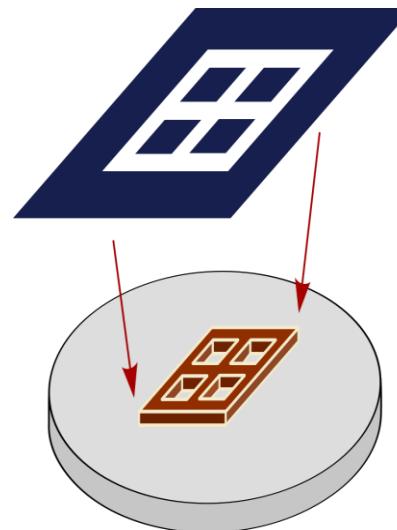
Photo Mask

A photomask is an opaque plate with holes or transparencies that allow light to shine through in a defined pattern

- Lithographic photomasks are typically transparent fused silica blanks covered with a pattern defined with a chrome metal absorbing film.
- Use e-beam or laser or x-ray to strip off chromium
- For Integrated Circuits, multiple masks with multiple pattern are necessary.

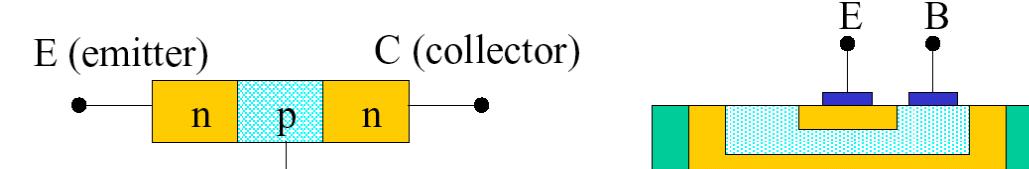


Mask is the primary source of the pattern that gets transferred to the PR Layer during Exposure.



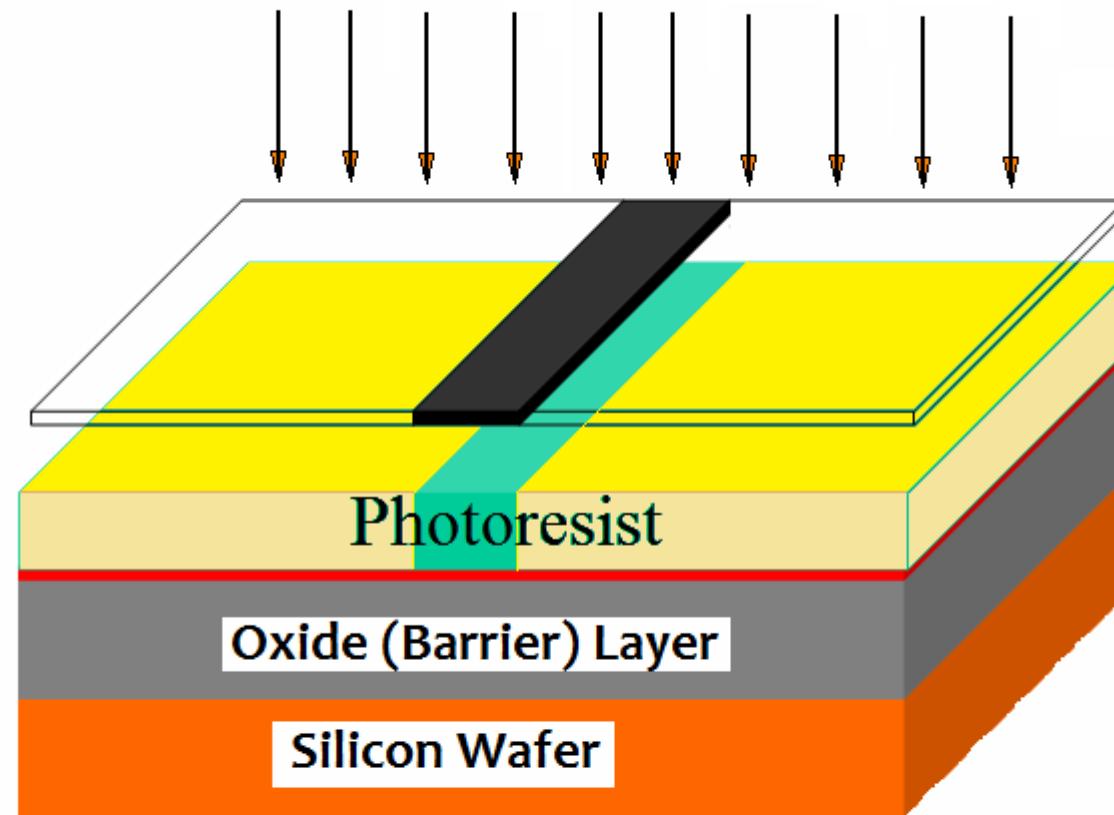
Mask Aligners:

- Almost any microscale device or structure requires more than one photomask step.
- The job of the aligner is to allow its user to align features on a substrate (wafer) to features on a photomask.
- The production of sophisticated electronic devices may involve ten or more of these alignment steps.



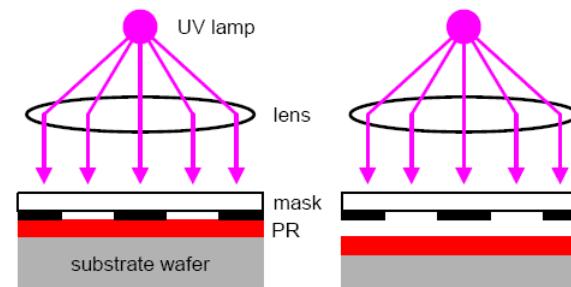
Mask Aligner

Expose



Optical Exposure: Printing Modes

Contact Printing

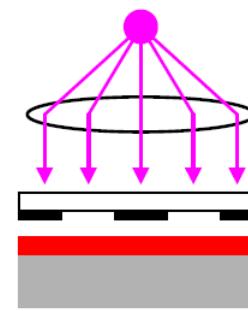


2 operating modes:
contact for expose;
separate for align.

Examples:
Kaspar 17A
Oriel
Karl Suss MJB3

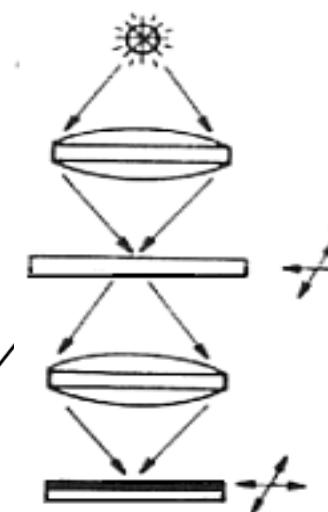
Projection systems use imaging optics
in between the mask and the wafer

Proximity Printing



Examples:
Kaspar-Cobalt

Projection Printing



Proximity printer resolution versus gap.

Gap (μm)	Resolution (μm)
10	1.47
15	1.77
20	2.03
30	2.46

Contact Printing

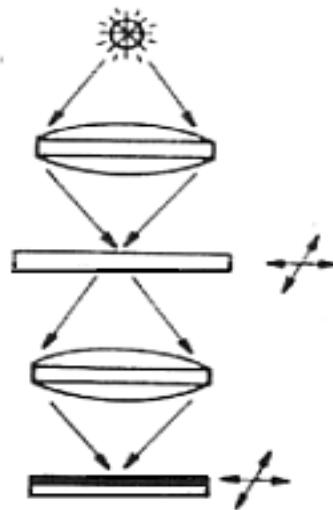
- The resist-coated silicon wafer is kept at physical contact with the photomask during exposure.
- Because of the contact between the resist and mask, very high resolution is possible in contact printing (e.g. 1-micron features)
- The problem with contact printing is that debris, trapped between the resist and the mask, can damage the mask and cause defects

Proximity Printing

- The proximity exposure method is similar to contact printing except that a small gap ~ 10 to 25 microns, is maintained between the wafer and the mask during exposure.
- This gap minimizes (but may not eliminate) mask damage. Approximately 2- to 4-micron resolution is possible with proximity printing

Projection Printing or Alignment

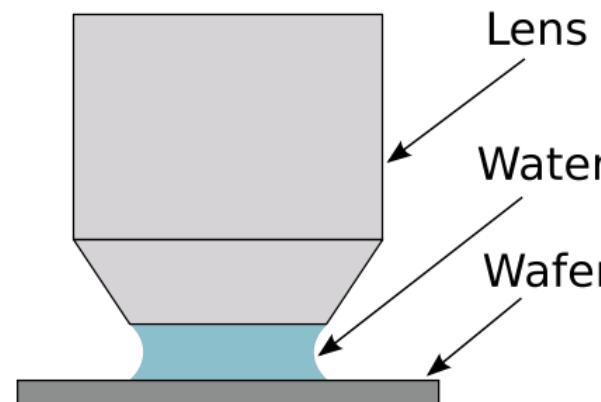
Projection Printing



Projection Printing

- Projection printing, avoids mask damage entirely.
- An image of the patterns on the mask is projected onto the resist-coated wafer, which is many centimeters away.
- In order to achieve high resolution, only a small portion of the mask is imaged.
- This small image field is scanned or stepped over the surface of the wafer.
- Projection printers that step the mask image over the wafer surface are called step-and-repeat systems.
- Step-and-repeat projection printers are capable of approximately 1-micron resolution.

Most present day photo lithography instruments work on this principle



Immersion Lithography

A photolithography resolution enhancement technique that replaces the usual air gap between the final lens and the wafer surface with a liquid medium that has a refractive index greater than one.

The resolution is increased by a factor equal to the RI of the liquid.

Enhancement in Numerical Aperture



Post Bake

Post bake is performed after exposure, at temperatures slightly higher than soft bake.

Developing

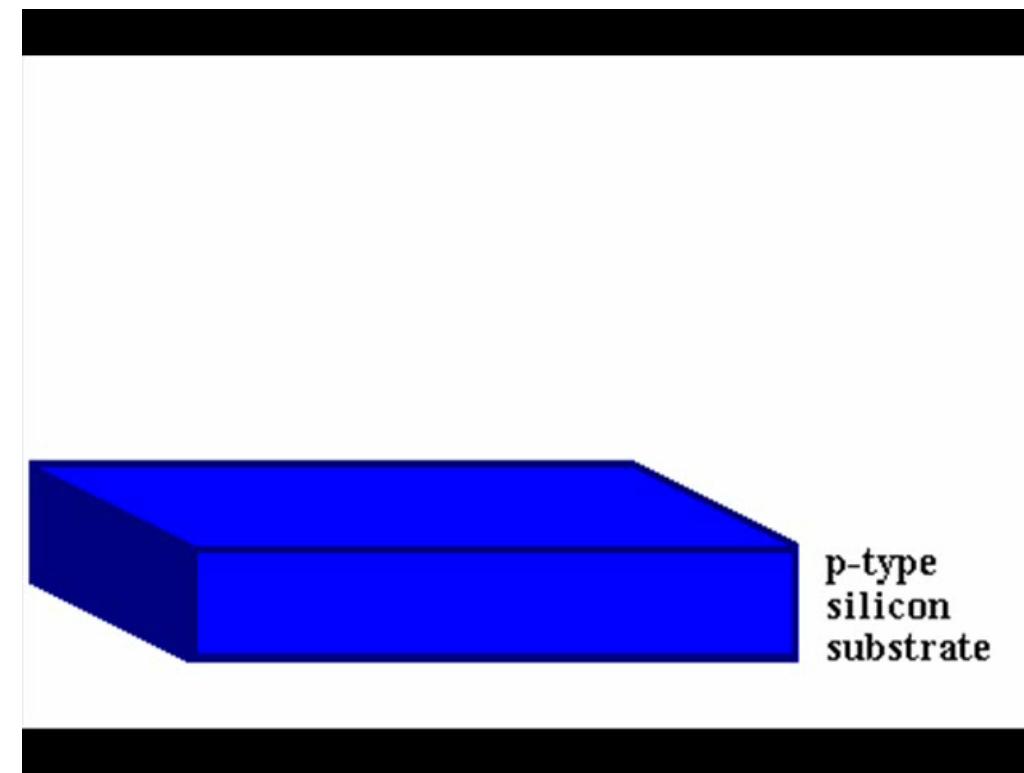
This step a special solvent is used to wash the exposed/ un-exposed photo resist layer, resulting in the patterns on the PR layer.

Hard Bake

Final baking step to increase stiffness of the patterned photo resist layer and increase adhesion as well

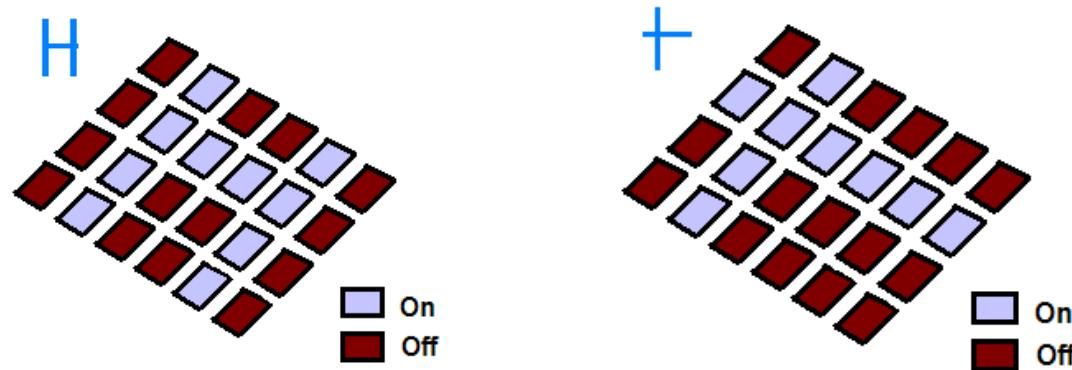
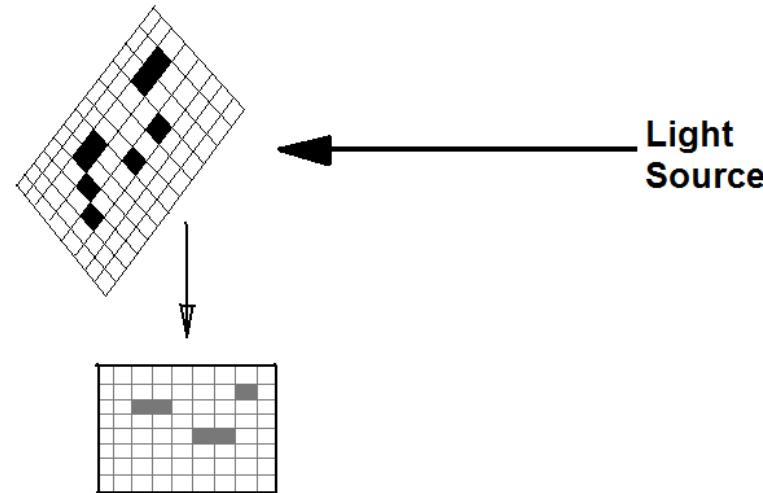
Photolithography Process: Basic Steps

1. Surface Preparation
2. Deposition of the Barrier Layer (SiO_2)
3. Photoresist Application
4. Soft Bake
5. Mask Align
6. Expose to UV
7. Develop
8. Hard Bake
9. Etch
10. Resist Strip



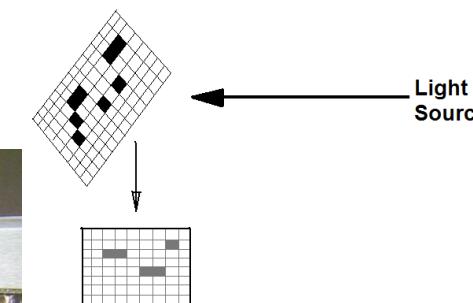
Mask Less Lithography

Array of micro mirrors, each one of which can be either “ON” or “OFF”



Lowest resolution possible is $\sim 5 \mu\text{m}$

Mask less Lithography



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Photolithography: Limitations

- (1) It requires expensive instruments and facilities with high capital investment
- (2) The pattern resolution is limited by optical diffraction
- (3) The method is not suitable for patterning all types of polymers, and only photosensitive resist materials (photoresists) can be directly patterned
- (4) The technique requires harsh processing conditions such as exposure to UV radiation, chemical etching, and so on, and therefore has limited application for sensitive materials such as biological samples with living cells
- (5) the method cannot be easily applied for patterning of nonplanar or curved surfaces